Power MOSFET and Schottky Diode

-20 V, -3.9 A FETKY®, P-Channel, 2.0 A Schottky Barrier Diode, DFN6

Features

- Flat Lead 6 Terminal Package 3x3x1 mm
- Enhanced Thermal Characteristics
- Low VF and Low Leakage Schottky Diode
- Reduced Gate Charge to Improve Switching Response
- This is a Pb-Free Device

Applications

- Buck Converter
- High Side DC–DC Conversion Circuits
- Power Management in Portable, HDD and Computing

MOSFET MAXIMUM RATINGS (T_{.J} = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	-20	V
Gate-to-Source Voltage)		V_{GS}	±12	V
Continuous Drain	Steady	$T_A = 25^{\circ}C$	I _D	-2.7	Α
Current (Note 1)	State	T _A = 85°C		-2.0	
	t ≤ 10 s	T _A = 25°C		-3.9	
Power Dissipation (Note 1)	Steady State T _A = 25°C		P _D	1.6	W
	t ≤ 10 s			3.0	
Continuous Drain		T _A = 25°C	I _D	-2.3	Α
Current (Note 2)	Steady	T _A = 85°C		-1.7	
Power Dissipation (Note 2)	State	T _A = 25°C	P _D	1.14	W
Pulsed Drain Current	t _p =	10 μs	I _{DM}	11	Α
Operating Junction and Storage Temperature			T _J , T _{STG}	–55 to 150	°C
Source Current (Body Diode)			IS	1.1	Α
Lead Temperature for So (1/8" from case for 10 s)		urposes	T _L	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).
- Surface Mounted on FR4 Board using the minimum recommended pad size (Cu area = 0.5 in sq).



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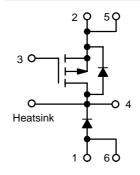
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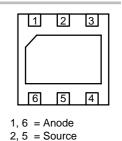
MOSFET

V _{(BR)DSS}	R _{DS(on)} TYP	I _D MAX
–20 V	110 mΩ @ –4.5 V	-3.9 A

SCHOTTKY DIODE

V _R MAX	V _F TYP	I _F MAX
20 V	0.36 V	2.0 A





= Gate= Drain/Cathode

MARKING DIAGRAMS



DFN6 CASE 506AH



3402 = Specific Device Code A = Assembly Location Y = Year

WW = Work Week
■ Pb-Free Package

ORDERING INFORMATION

Device	Package	Shipping [†]
NTLGF3402PT1G	DFN6 (Pb-Free)	3000 / Tape & Reel
NTLGF3402PT2G	DFN6 (Pb-Free)	3000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

SCHOTTKY DIODE MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Max	Unit
Peak Repetitive Reverse Voltage	V_{RRM}	20	V
DC Blocking Voltage	V_R	20	V
Average Rectified Forward Current	l _F	2.0	Α

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 2)	$R_{ heta JA}$	110	°C/W
Junction–to–Ambient – $t \le 10 \text{ s}$ (Note 2)	$R_{ heta JA}$	58	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{ heta JA}$	79	°C/W
Junction–to–Ambient – $t \le 10 \text{ s}$ (Note 3)	$R_{ hetaJA}$	41	°C/W

^{3.} Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).

MOSFET ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Conditions		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = -25$	50 μA	-20			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				-9.0		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}		T _J = 25°C			-1.0	μΑ
		$V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V}$	T _J = 125°C			-5.0	1
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm$	12 V			±100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = -2$	50 μΑ	-0.6		-2.0	V
Gate Threshold Temperature Coefficient	V _{GS(TH)} /T _J				2.7		mV/°C
Drain-to-Source On-Resistance	R _{DS(on)}	$V_{GS} = -4.5$, $I_D = -2.7$ A			110	140	mΩ
		$V_{GS} = -2.5$, $I_D = -1.0$ A			190	225	
Forward Transconductance	9FS	$V_{DS} = -10 \text{ V}, I_D = -2.7 \text{ A}$			4.8		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{ISS}				230	350	pF
Output Capacitance	C _{OSS}	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$ $V_{DS} = -10 \text{ V}$			105	225	
Reverse Transfer Capacitance	C _{RSS}	v _{DS} = -10 v			40	75	1
Total Gate Charge	$Q_{G(TOT)}$				3.8	10	nC
Threshold Gate Charge	Q _{G(TH)}	$V_{GS} = -4.5 \text{ V}, V_{DS} =$	–10 V,		0.32		1
Gate-to-Source Charge	Q_{GS}	$V_{GS} = -4.5 \text{ V}, V_{DS} = -10 \text{ V},$ $I_{D} = -2.7 \text{ A}$			0.7		1
Gate-to-Drain Charge	Q_{GD}				1.6		1
SWITCHING CHARACTERISTICS (No	ote 5)						
Turn-On Delay Time	t _{d(ON)}	$V_{GS} = -4.5 \text{ V}, V_{DD} = -16 \text{ V},$ $I_{D} = -2.7 \text{ A}, R_{G} = 2.4 \Omega$			6.2	15	ns
Rise Time	t _r				22	30	1
Turn-Off Delay Time	t _{d(OFF)}				25	45	
Fall Time	t _f				34	60	1

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

$\textbf{MOSFET ELECTRICAL CHARACTERISTICS} \ (T_J = 25^{\circ}\text{C unless otherwise noted})$

· ·							
Parameter	Symbol	ol Test Conditions		Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CHARACTERISTICS							
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 \text{ V}, I_{S} = -1.1 \text{ A}$	T _J = 25°C		-0.8	-1.2	V
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, } I_{S} = -1.1 \text{ A ,}$ $dI_{S}/dt = 100 \text{ A/}\mu\text{s}$			53		ns
Charge Time	t _a				15		1
Discharge Time	t _b				38		
Reverse Recovery Charge	Q_{RR}				37		nC

$\textbf{SCHOTTKY DIODE ELECTRICAL CHARACTERISTICS} \ (T_J = 25^{\circ}\text{C unless otherwise noted})$

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
Maximum Instantaneous	V _F	I _F = 0.1 A		0.32	0.34	V
Forward Voltage		I _F = 1.0 A		0.36	0.39	
Maximum Instantaneous	I _R	V _R = 5 V, T _J = 100°C			12	mA
Reverse Current		V _R = 10 V		70		μΑ
		V _R = 20 V		225		

^{6.} Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
7. Switching characteristics are independent of operating junction temperatures.

TYPICAL P-CHANNEL PERFORMANCE CURVES

(T_J = 25°C unless otherwise noted)

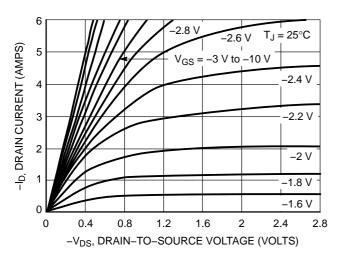
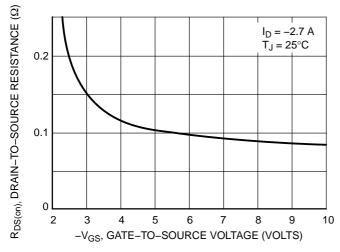


Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



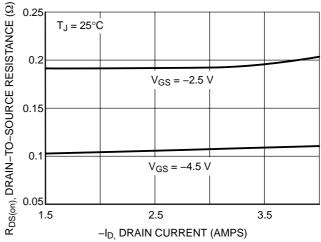
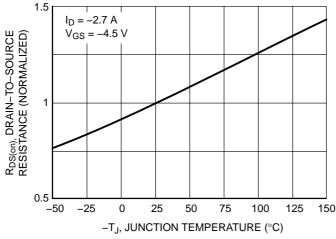


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



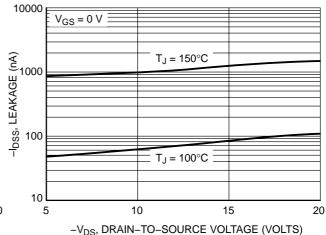
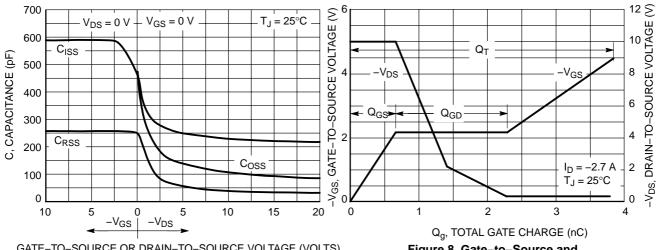


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

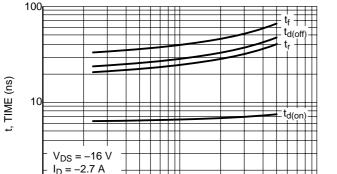
TYPICAL P-CHANNEL PERFORMANCE CURVES

(T_J = 25°C unless otherwise noted)



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 7. Capacitance Variation



R_G, GATE RESISTANCE (OHMS)

 $V_{GS} = -4.5 \text{ V}$

Figure 9. Resistive Switching Time Variation vs. Gate Resistance

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Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

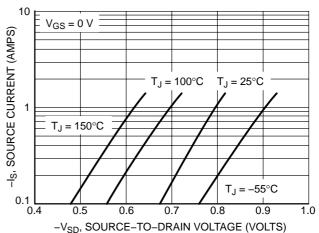
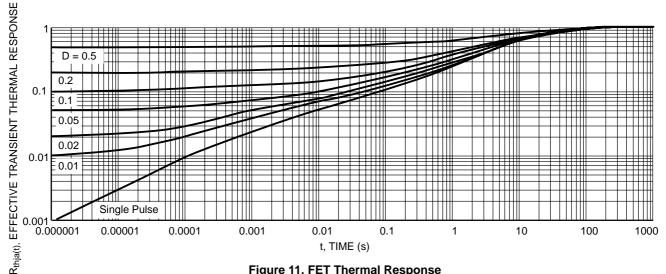


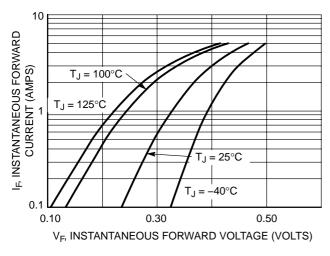
Figure 10. Diode Forward Voltage vs. Current



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Figure 11. FET Thermal Response

TYPICAL SCHOTTKY PERFORMANCE CURVES (T_J = 25°C unless otherwise noted)

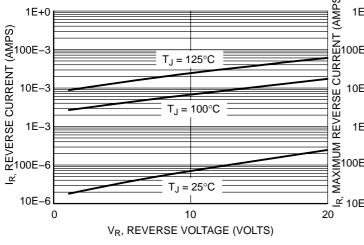


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Figure 12. Typical Forward Voltage

VOLTAGE (VOLTS)

Figure 13. Maximum Forward Voltage



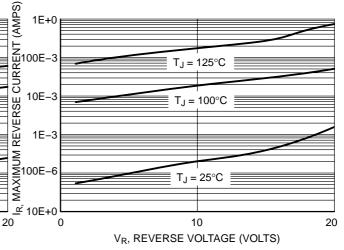
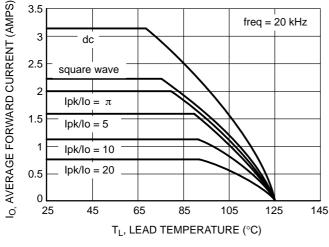


Figure 14. Typical Reverse Current

Figure 15. Maximum Reverse Current



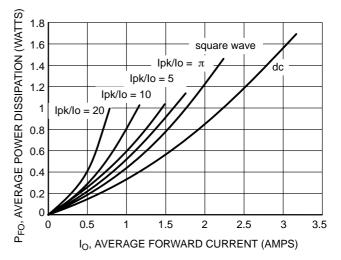


Figure 16. Current Derating

Figure 17. Forward Power Dissipation

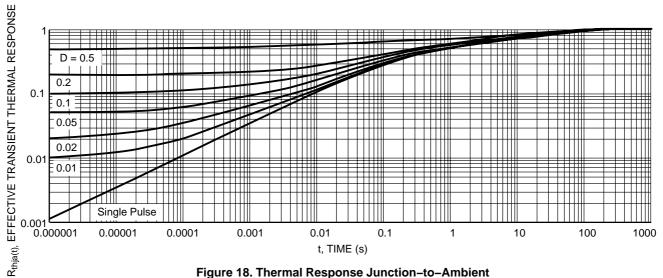
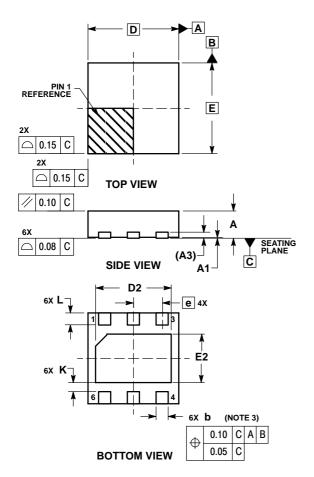


Figure 18. Thermal Response Junction-to-Ambient

PACKAGE DIMENSIONS

DFN6 3*3 MM, 0.95 PITCH

CASE 506AH-01 ISSUE O

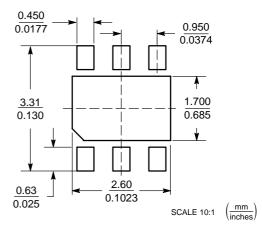


NOTES:

- DIMENSIONS AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: MILLIMETERS.
- DIMESNION & APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.25 AND 0.30 MM FROM TERMINAL.
- 4. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

	MILLIMETERS							
DIM	MIN	NOM	MAX					
Α	0.80	0.90	1.00					
A1	0.00	0.03	0.05					
A3	0	0.20 REF						
b	0.35	0.40	0.45					
D	3	.00 BSC	;					
D2	2.40	2.50	2.60					
E	3	.00 BSC	;					
E2	1.50	1.60	1.70					
е	0.95 BSC							
K	0.21	-						
L	0.30	0.40	0.50					

SOLDERING FOOTPRINT*



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